

<b>Notice of References Cited</b>	Application/Control No. 10/749,250	Applicant(s)/Patent Under Reexamination LEE, WOO-JIK	
	Examiner T. M. Argenbright	Art Unit 3747	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0230289 a1	12-2003	Yamaoka et al.	123/527
	B	US-6,786,201	09-2004	Ohtani, Motoki	123/491
	C	US-6,766,269	07-2004	Lee, Woo-Jik	123/527
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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